

**Search Notes**

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Examiner

Binh V. Ho

Applicant(s)/Patent under  
Reexamination

LEE ET AL.

Art Unit

2163

**SEARCHED**

Class	Subclass	Date	Examiner
707	6	6/6/2006	BH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
707/6,1-5,200,205	6/6/2006	BH